Experimental investigation of the formation of nano-indentations in thin polymer films

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Introduction

Experimental setup description

- Atomic Force Microscopy (AFM) setup
- Nano-indentation formation mechanism
- Imaging mechanism

□ Nano-indentation modeling

- Analytical 3-D model
- Experimental nano-indentation extraction
- Model fitting
- Performance results

Conclusions

Introduction

- Scanning probes with nanometer-sharp tips have been used extensively the last few years.
 - Nanolithography, imaging, etc
 - Ultra-high-density data storage
- In probe-based data storage, information is stored in the form of nanoscale indentations by locally altering the storage medium's properties.
 - Polymer shape (thermo-mechanically)
 - Phase change (electrically)

Investigate the effect of nanopositioning speed on the 3-D shape of indentations created on thin polymer films. <u>Motivation:</u>

- Analytical model of the indentation (simulation)
- Accuracy of detecting the stored information (adaptive detection)

AFM Experimental Setup



Nano-indentation formation mechanism



Duration: Heater temperature:	1μs – 5μs 350°C –500°C ~ 200°C – 200°C
Force :	50nN – 300nN (ESF~ 3V – 10V)

- □ The current that flows through the resistance heats the cantilever tip.
- An electrostatic force pulse applied
 between the cantilever and the
 substrate forces the tip to contact
 the underlying polymer.
- The heated tip softens the polymer forming an indentation.
- □ Indentation shape and dimensions:
 - Formation process parameters
 - Cantilever mounting angle
 - Scanner velocity during formation
 - Tip apex dimensions (wear) and shape (usually conical)

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Imaging mechanism: thermo-electrical



□ The temperature of the sensing element determines its resistance.

The resistance change over time is detected as a change in the voltage between the two cantilever legs.

3-D indentation model

- Polymer bulges around the edges of the indentation (RIMs).
 - Nano-indentations present:
 - asymmetric x-y widths
 - asymmetric x-y RIMs
 - asymmetric x-axis RIMs depending on the direction of motion
- Starting from a two dimensional Gaussian function, a modified two dimensional Laplacian of Gaussian parametric function is derived.



Example indentation obtained from experimental data

The proposed model captures the asymmetric shape of the 3-D indentation:

$$S(x, y) = p_1 \left[\frac{p_4 \left(1 + \left[0.5(\text{sgn}(x) - 1) \right] p_6 \right) x^2 - p_2^2}{p_2^4} + \frac{p_5 y^2 - p_3^2}{p_3^4} \right] \exp \left[- \left(\frac{x^2}{2p_2^2} + \frac{y^2}{2p_3^2} \right) \right]$$

where $\mathbf{p} = [p_1 p_2 p_3 p_4 p_5 p_6]^T$ the vector of the function's coefficients.

Experimental nano-indentation extraction



Averaging for extraction of the mean experimental indentation per scan velocity

Model fitting to experimental average indentations



- □ Find *p* such that *S(x,y)* best fits the average experimental indentation for each scan velocity.
- □ The optimal solution is obtained using non-linear least squares.

Performance results

velocity 0.5 mm/s



velocity 0.2 mm/s



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- An analytical 3-D model of nano-indentations engraved on a thin polymer film has been derived.
- The model was based on experimental data obtained using an AFM-based setup equipped with thermomechanical cantilevers.
- The model captures well the asymmetry and shape of the actual indentation and adapts well when the velocity of the scanner during the formation process varies.
- □ The error between the two surfaces in terms of euclidean distance is below 20% of the maximum indentation depth.